

RoHS H/F

MSL Level 1

# Approval Sheet

Products	Dielectric Chip Antenna						
Customer		PARTRON					
Model	I	Bluetooth Headset					
Customer CODE							
Supplier		PARTRON					
Supplier CODE	ACS2450HFL57						
	By designed	By checked	By approved				
PARTRON	피 강 욱	alting	领父				
	Antenna 2 Team	Quality Assurance	Laboratory				
	Kanguk. Pi	Nam-Sik. Min	Byoung-Jun.Yim				
	09/19	09/19	09/19				

2014 . 09. 19



22-6, Seokwoo-dong, Hwaseong-si, Gyeonggi-do, 445-170, KOREA Tel : 82-31-201-7870~6 Fax : 82-31-201-7800 www.partron.co.kr



RoHS H/F

MSL Level 1

# MODEL : ACS2450HFL57

## **DIELECTRIC CHIP ANTENNA**

By designed	By checked	By approved	
피 강 욱	aling	领父	
Antenna 2 Team	Quality Assurance	Laboratory	
Kanguk. Pi	Nam-Sik. Min	Byoung-Jun.Yim	
09/19	09/19	09/19	
	014 . 09. 1		

Ver 1.0 (2014.09.19)



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#### 1. Revision

Revision No	Originator	Description of changes	Date of changes
Ver 1.0	Kanguk. Pi	Issued	2014.09.19



#### 2. Electrical Characteristics

#### 2.1 Set Condition

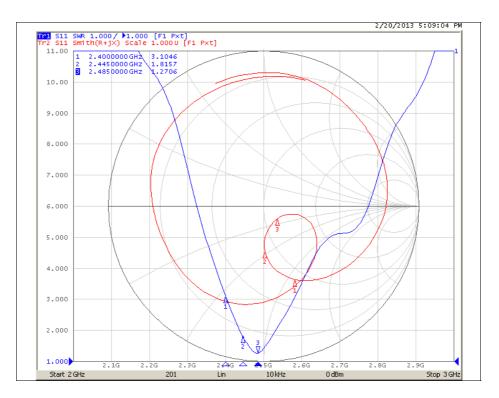
	ITEM		SPEC
Frequen	cy Range [MHz]	2400 ~ 2485	
VS	SWR [Max]		3 : 1
Band	dwidth [MHz]		85
Р	olarization		Linear
Matching Value of	Antenna Matching Circuit	Series2 (Feed)	2.2nH
ANT Matching Circuit	T-Matching Circuit	Shunt	1.0pF
(Direction, from Antenna to Module)	Circuit (nearby Module)	Series1	1.0nH
	Azimuth Plane	Peak	1.27
		Average	-1.37
		Peak	0.63
	Elevation1 Plane	Average	-4.50
Gain[dBi]		Peak	-1.42
	Elevation2 Plane	Average	-5.25
	0.0	Peak	1.25
	3D	Average	-4.21

#### 2.2 Test Fixture Condition

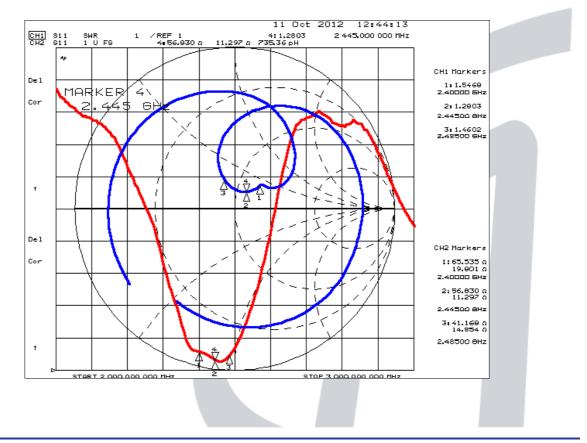
ITEM	SPEC		
Frequency Range [MHz]	1840 ~ 1920		
SWR [Max]	4.0 : 1		
Bandwidth [MHz]	80		



2.3 Graph of Set Condition

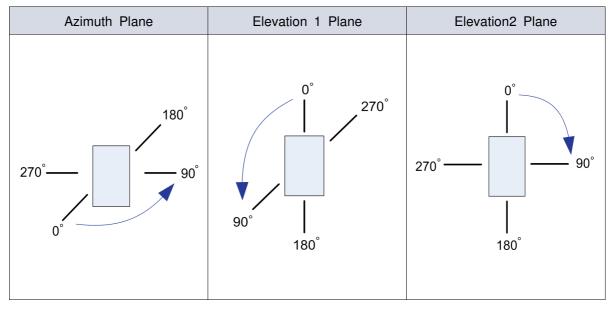


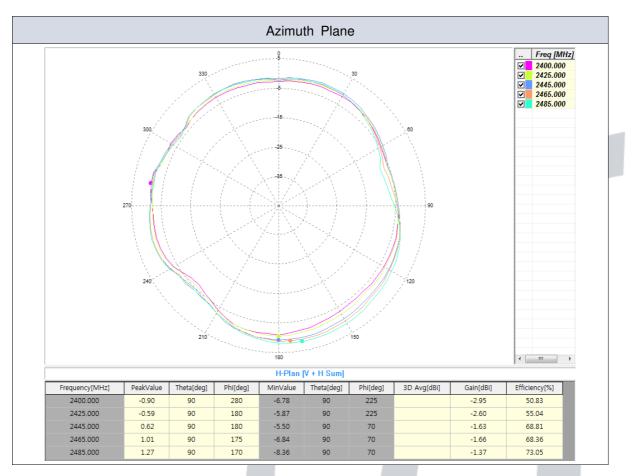
2.4 Graph of Test Fixture Condition





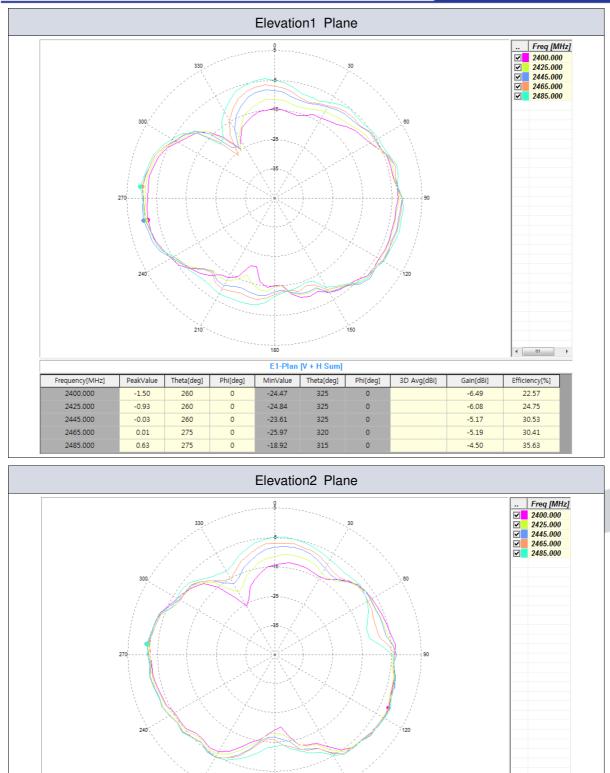
#### 2.5 Radiation Pattern





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	190							∢	
	E2-Plan [V + H Sum]								
Frequency[MHz]	PeakValue	Theta[deg]	Phi[deg]	MinValue	Theta[deg]	Phi[deg]	3D Avg[dBi]	Gain[dBi]	Efficiency[%]
2400.000	-2.05	115	90	-25.71	330	90		-6.35	23.28
2425.000	-1.94	275	90	-20.24	330	90		-6.26	23.76
2445.000	-1.26	275	90	-16.89	180	90		-5.58	27.75
2465.000	-1.57	275	90	-16.10	185	90		-5.73	26.86
2485.000	-1.42	275	90	-14.00	175	90		-5.25	29.95

150

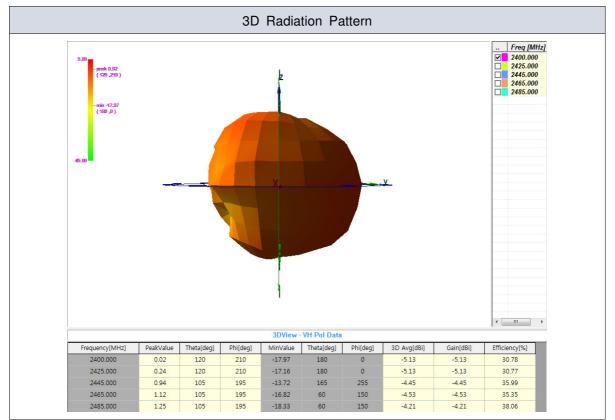
210

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2.6 3D Radiation Pattern



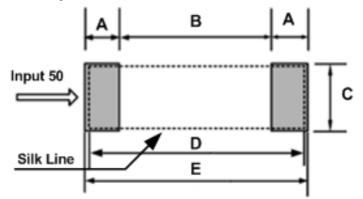
#### 3. Mechanical Characteristics

- The structure is materialized printing Ag paste at the dielectric block
- 3.1 Structure and Material

Motorial	Dielectric Block	3D Structure						
Material	Ag Paste	Ag paste						
	W = 2.0±0.1							
Size [mm]	$L = 6.0 \pm 0.1$							
	T 10101	Dielectric Block						
	$T = 1.2\pm0.1$	Top-Side View Bottom-Side View						
Temperature [℃]		- 40 ~ +80						
Humidity [%]		At the normal temperature, RH 100						



#### 3.2 PCB Layout & Soldering Pad Dimension

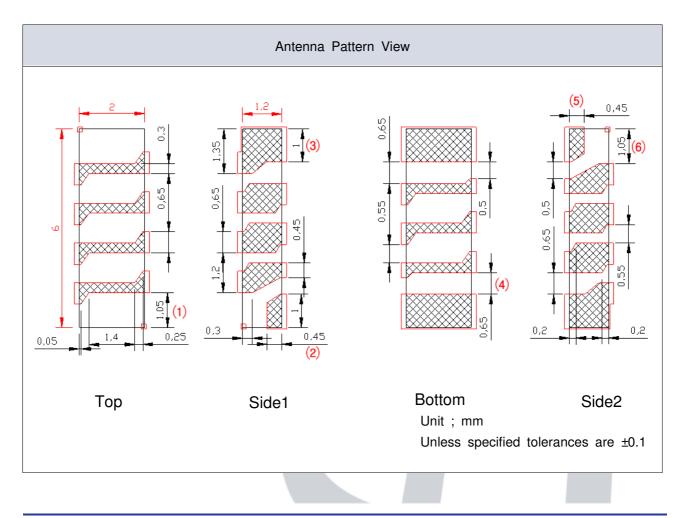


Parameter	А	В	С	D	E
Value[mm]	1.2	4.0	2.4	6.0	6.4

Unit; mm

Unless specified tolerances are ±0.1

#### 3.3 Antenna Pattern Dimension

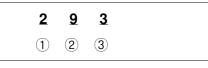


# *P*partron

#### 3.3.1 Real Measurement Value

	(1)	(2)	(3)	(4)	(5)	(6)
Drawing Dimension [mm]	1.05±0.1	0.45±0.1	1.0±0.1	0.65±0.1	0.45±0.1	1.05±0.1
1	1.136	0.440	1.033	0.640	0.513	1.099
2	0.962	0.460	0.953	0.634	0.509	1.036
3	1.036	0.507	1.026	0.645	0.470	1.108
4	1.122	0.490	1.022	0.640	0.474	1.080
5	0.982	0.461	0.970	0.669	0.503	1.073
Min [mm]	0.962	0.440	0.953	0.634	0.470	1.036
Max [mm]	1.136	0.507	1.033	0.669	0.513	1.108
Average [mm]	1.048	0.472	1.001	0.646	0.494	1.079

#### 3.4 LOT Notation



① Year ; 1 - 2011, 2 - 2012,  $\cdots$  9 - 2019, 0 - 2020  $\cdots$ 

2 Month ; 1 - January, 2 - February,  $\cdots$  A - October, B - November  $\cdots$ 

③ Date ; 1 - 1st, 2 - 2nd, 3 - 3rd … H - 17th, I - 18th …

#### 3.5 Marking





#### 4. Measurement Process

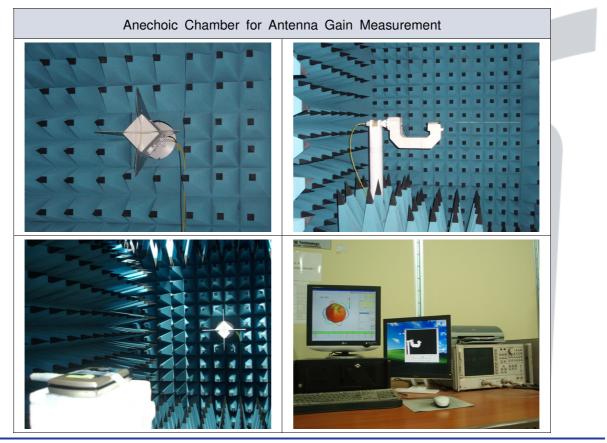
#### 4.1 SWR/Returnloss

-The SWR/Returnloss is measured by Network Analyzer

	Set Condition	Test Fixture Condition
Network Analyzer	Agilent HP8753Dor Advantest R3765CG	Agilent HP8753D or Advantest R3765CH
Cable	RF cable(300mm)	RF cable(300mm)
Test condition		

#### 4.2 Gain

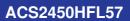
-The Antenna Gain is measured using the set at Anechoic Chamber





### 5. Primary Inspection List

Item	Electrical Characteristic [MHz]		Electrical Characteristic [MHz] [mm]			
Standard	VSWR 4.0 : 1 [Max]		W=2 0+0 1		T=1.2±0.1	
1	2.21	1.99	2.03	6.02	1.23	
2	2.06	2.13	2.04	6.01	1.24	
3	1.96	2.11	2.04	6.00	1.24	
4	2.09	2.06	2.05	6.01	1.24	
5	1.98	2.23	2.04	6.00	1.24	
6	2.10	1.97	2.04	6.01	1.25	
7	1.95	2.27	2.04	6.01	1.24	
8	1.88	2.38	2.03	6.00	1.23	
9	2.04	2.14	2.04	6.01	1.24	
10	2.08	2.04	2.03	6.01	1.24	
11	1.81	2.38	2.04	6.02	1.24	
12	2.03	1.99	2.05	6.01	1.25	
13	2.32	1.84	2.04	6.03	1.24	
14	1.94	2.16	2.05	6.00	1.25	
15	1.83	2.44	2.04	5.99	1.24	
16	2.28	1.83	2.06	6.02	1.24	
17	2.33	1.79	2.04	6.00	1.25	
18	2.17	1.89	2.04	6.01	1.25	
19	1.66	2.22	2.03	6.01	1.24	
20	1.68	2.33	2.04	6.00	1.23	
Х	2.02	2.11	2.04	6.01	1.24	
σ	0.19	0.19	0.01	0.01	0.01	
Cpk	3.42	3.20	2.58	3.23	4.67	
Decision	ОК	ОК	ОК	ОК	ОК	





#### 6. Reliability Condition

#### 6.1 ENVIRONMENT TEST

ITEM	TEST CONDITION	LIMIT
High Temperature	+85℃±3℃, 120hr	*After the test,
Resistance	100 0 10 0, 12011	specimen would be kept at
Low Temperature	-40℃±3℃,120hr	$25^{\circ}\pm5^{\circ}$ for 1 hours
Resistance	-40 0 13 0 , 12011	
Humidity Resistance	+60±3℃, RH90~95% ,120hr	*specimen sheet meet the electrical specification

#### 6.2 Thermal Shock Test , Reflow Test

ITEM	TEST CONDITION	LIMIT
	-40 ℃±3 ℃/30min ↔ +85 ℃±3 ℃/30min	
Thermal Shock	cycle : 15 cycle	
	recovery time : with in 5min	SAME as 6-1
Reflow	Pre Heating 200 $\pm$ 5 $^{\circ}$ , 30 $^{\sim}$ 60 sec	
nellow	Peak Heating 260℃±5℃,30sec Max	

#### 6.3 Mechanical Test

ITEM	TEST CONDITION	LIMIT
Random Vibration	Frequency 10~500Hz - 10 $\times$ 9.8% (G) Sweep time 15min , X.Y.Z each 5 times	*After the test, specimen sheet meet the
Drop	Height 152cm , 5 times (Each Surface)	electrical specification

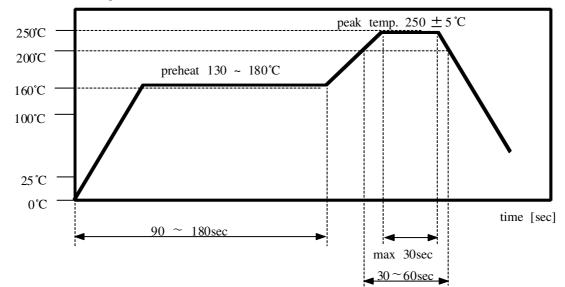
#### 6.4 Reliability Test Result

\* Appendix



#### 7. Soldering Condion

7.1 Reflow Soldering



#### 7.2 Manual Soldering

Pre-heating Temperature :  $120\,^\circ\!\!C$  ,  $60\,\,\sim\,\,300\,$  sec. Soldering Temperature :  $340\,^\circ\!\!C\,\pm\!\!5\,^\circ\!\!C$  , 5sec max per each terminal

#### 8. Attention

#### 8.1 Temperature Condition

	Range of Temperature	unit	
Application	-40 ~ +85	°C	
Keeping	-40 ~ +85	Ĵ	
		1	J

#### 8.2 MSL LEVEL 1 (JEDEC J-STD-020C)

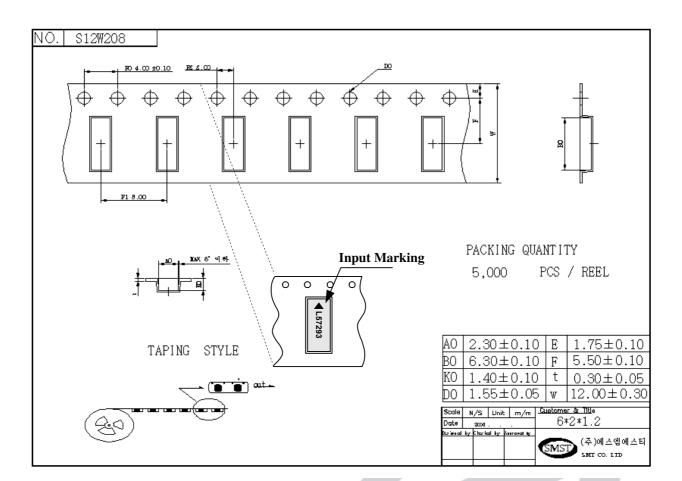
	FI	oor Life	Soak Requirements				
	Time	Conditions	Time Conditions				
1	Unlimited	= < 30℃/85%RH	168+5/-0	= < 85℃/85%RH			



#### 9. Packing

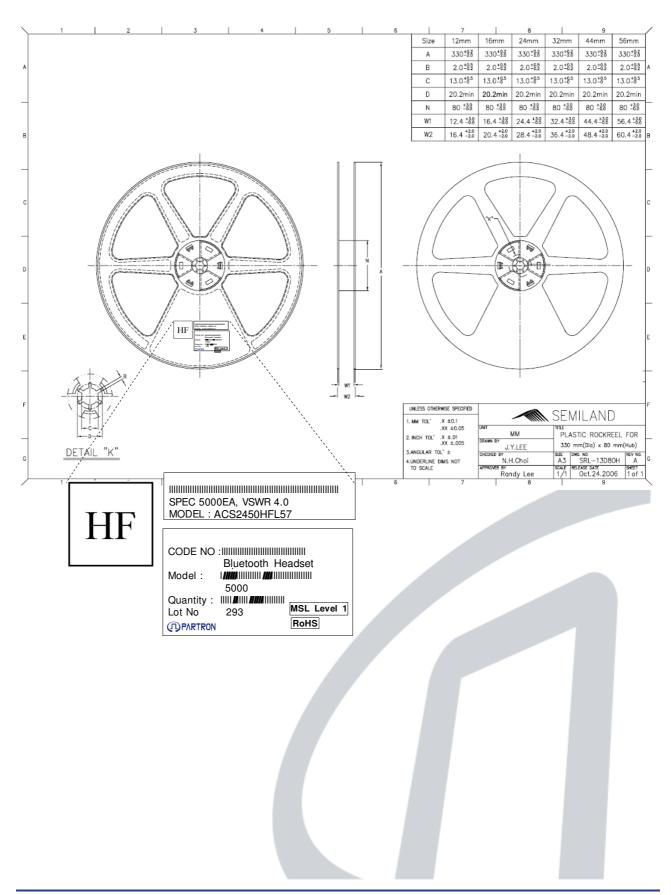
#### 9.1 Carrier/Reel

ITEM	Material	Surface Resistance	Packing Method
Carrier	A-PET	Typical 10 <sup>8</sup> Ω	Heat press
Reel	A-PET		Air press (Using S-460G)



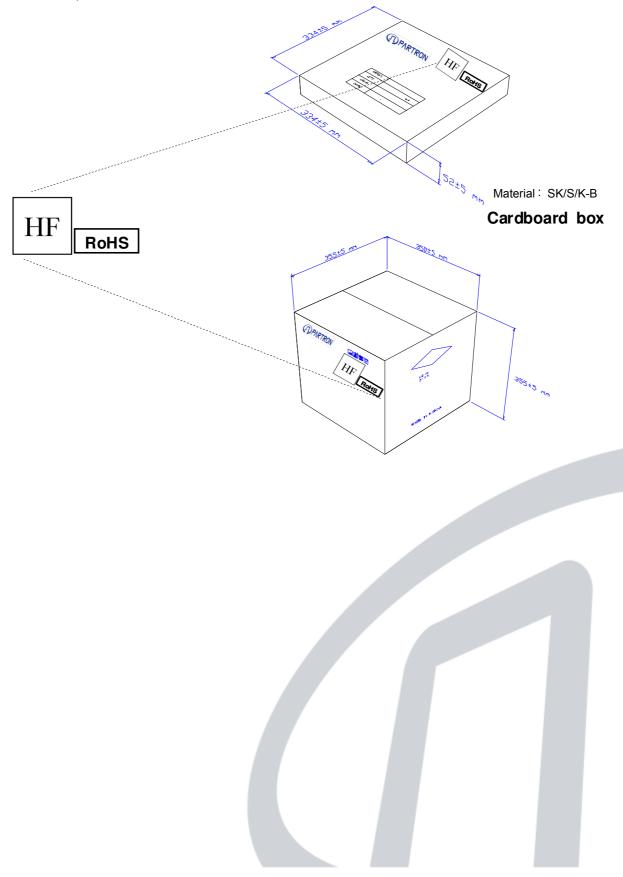
# Reartron

ACS2450HFL57





#### 9.2 Box Specification





#### 10. Process Control

	Produc	t	Issue	ed/Revisior	1	-		<b>.</b>		Record	By desig	ned By che	cked a	By oproved
CHI	p ante	ENNA	Issued Revised	04.04.0 05.04.0		Proc	cess (	Control		PRCP-C0	01			
	FLOW	CHART			Mana	Management of Factors				Ν	Management of quality			
Input Materials	prepar ation	Main Process	Process name	Equipmen t Name	Checked	Condition	Cycle of managem ent	Record	Checked Item	Margin	Method of Inspection	Cycle of management	Record	Action
Ceramic POWDER		$\bigcirc$	Import Inspection						shrinking rate permittivity	refer to Guide Sheet	Micrometer Network	10ea/LOT	C/sheet	Return
POWDER lubricant	$\bigcirc$		powder	Mixer					mixing	POWDER lubricant	Scale	PER MIXING	-	Exhaust
		$\bigcirc$	Shaping CTQ Process (Weight, dimension)	Press	pressure Mold Condition	refer to Guide Sheet	Per LOT 1/day	parameter C/SHEET	dimension weight density aspect	refer to Guide Sheet	Micrometer scale Calculated Visual	5/100EA 10ea/lot	LOT CARD	Exhaust
		$\bigcirc$	Plasticity	Plasticity Hole	SETTER Outside Temperature PROFILE	refer to Guide Sheet	all 2/day 1/month	C/sheet						
		$\bigcirc$	Block CTQ Process (dimension)						wide length shape	refer to Guide Sheet	Micrometer Calipers Visual Inspection	20ea/LOT 20ea/LOT on all	C/sheet	Exhaust
AG PASTE		$\bigcirc$	SIDE1 PAD Printing CTQ Process (Printing dimension)	Printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN Dimension aspect	refer to Guide Sheet	Microscope	10ea/3Jig	c/sheet	Rework
		$\bigcirc$	Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	on all	Lot card	Rework

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	Produc	t	ls	sued/Revisior	ı					Record	By designed	By chec	ked By	approved
СНІ	p ante	INNA	Issue Revise			Process Control			PRCP-C0	01				
	FLOW	CHART	D		Manag	Management of Factors					Management of quality			
Input Materials	prepara tion	Main Process	Process name	Equipment Name	Checked	Condition	Cycle of managem ent	Record	Checked Item	Margin	Method of Inspection	Cycle of management	Record	Action
AG PASTE		$\bigcirc$	SIDE 2 PAD Printing CTQ	Printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN Dimension aspect	refer to Guide Sheet	Microscope	10ea/3Jig	c/sheet	Rework
		$\bigcirc$	Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework
		$\bigcirc$	Baking	Baking Hole mesh net	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter C/Sheet	Breakage Pollution	refer to Guide Sheet	Visual Inspection	all	Lot card	Exhaust Rework
AG PASTE		$\bigcirc$	TOP printing CTQ	Printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN dimension	refer to Guide Sheet	measure	10ea/3Jig	c/sheet	Rework
		$\bigcirc$	Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework
AG PASTE		$\bigcirc$	BOTTOM PAD Printing CTQ	printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN dimension aspect	refer to Guide Sheet	measure Microscope	10ea/3Jig	c/sheet	Rework

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### ACS2450HFL57

n	Produc	t	lse	sued/Revision	ı						Recor	d By	By	/	Ву
СН	IP ANTE	ENNA	Issued Revise			Process Control PRCP-C001					001				
la su st	FLOW	CHART	Dueses		M	anagen	gement of Factors				Management of	quality	uality		
Input Materials	prepara tion	Main Process	Process name	Equipment Name	Check	ked	Condition	Cycle of management	Record	Checked Item	Margin	Method of Inspection	Cycle of management	Record	Action
		$\bigcirc$	Dry	Dryer Dry Jig	Tempera Belt sp		refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework
		$\bigcirc$	Baking	Baking Hole mesh net	Tempera Belt sp	ature eed	refer to Guide Sheet	1/week	Parameter C/Sheet	Breakage Pollution	refer to Guide Sheet	Visual Inspection	all	Lot card	Exhaust Rework
		$\bigcirc$	aspect inspection							aspect	Reference SPL refer to Guide Sheet	Visual Inspection microscope	all	Lot card production diary	Exhaust repair
		$\bigcirc$	MARKING	Marking Machine						marking	Reference SPL	Visual Inspection	all	Lot card production diary	Rework Exhaust
		$\bigcirc$	Electrical Characteristic CTQ	NETWORK	proofrea Conditi		refer to Guide Sheet	1/2hour	C/sheet	Electrical Characteristic	refer to Guide Sheet	Network	all	Lot card production diary	Exhaust repair
		$\bigcirc$	aspect inspection							aspect dimension	Reference SPL refer to Guide Sheet	Visual Inspection microscope	all	Lot card production diary	Exhaust repair
Carrier cover reel		$\bigcirc$	Taping							Quantity Direction aspect	refer to Guide Sheet	Manual	all	Lot card production diary	Rework
		$\bigcirc$	shipper inspection	NETWORK	proofrea Conditi		refer to Guide Sheet	1/person	C/sheet	Electrical Characteristic aspect packing	refer to Guide Sheet	Network microscope Visual Inspection	refer to Guide Sheet	Result Paper	return Exhaust
packing box label		$\bigcirc$	packing	bar code printer						packing P/N Quantity	refer to Guide Sheet	Visual Inspection	all	-	Rework
		$\bigcirc$	packing inspection							packing P/N Quantity	refer to Guide Sheet	Visual Inspection	all	-	return

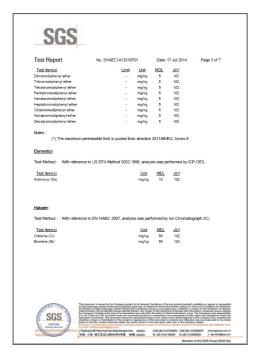


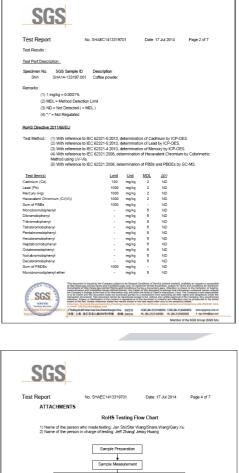
#### 11. 유해물질 성적서

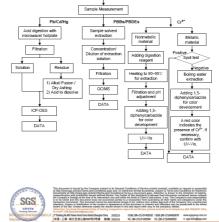
11.1 Ceramic Powder

Parts Name	Powder(iM-K8)
Tester Organization	SGS Testing KOREA co. Ltd.
Measurement Tester	Please see the 'method' in the test report
Measurement Data	Please see the report under the table

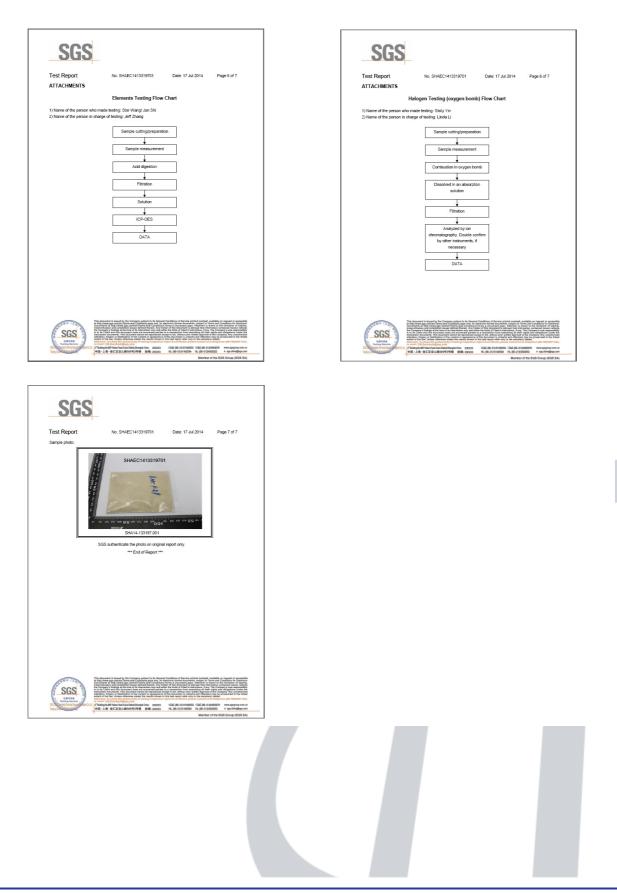
Test Report	No. SHAEC1413319701	Date: 17 Jul 2014	Page 1 of 7
WUXI INANOTECH CO.,LTE	2		
NO.518-3 ZHONGHUI ROAD	), WUXI, JIANGSU, CHINA (214174)		
The following sample(s) was	were submitted and identified on bei	half of the clients as : CERAN	/IC POWDER
SGS Job No. :	SP14-021760 - SH		
Model No. :	M-K38		
Composition :	BaTiO3		
Date of Sample Received :	15 Jul 2014		
Testing Period : Test Requested : Test Method :	15 Jul 2014 - 17 Jul 2014 Selected test(s) as requested by cl Please refer to next page(s).	ient.	
Test Results :	Please refer to next page(s).		
Conclusion :	Based on the performed tests on s Mercury, Cadmium, Hexavalent ch Polybrominated diphenyl ethers (P Directive 2011/65/EU Annex II; rec	romium, Polybrominated bipl BDEs) comply with the limits	henyls (PBBs),
Signed for and on behalf of SGS-CSTC Ltd.			
	_		













#### 11.2 Ag Paste

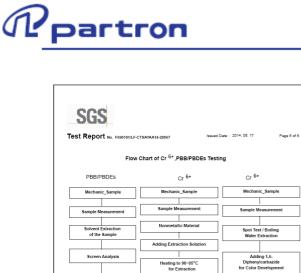
-	
Parts Name	Silver Paste
Tester Organization	SGS Testing KOREA co. Ltd.
Measurement Tester	Please see the 'method' in the test report
Measurement Data	Please see the report under the table

SGS			
•	No. F690101/LF-CTSAYAA14-28567 IS MATERIALS CO., LTD. 36	issued Date : 2014.08.17	Page 1 of 6
The following sample(s)	was/were submitted and identified by/on behalf o	f the client as:-	
SGS File No.	: AYAA14-28587		
Product Name	: Ag Paste		
Item No./Part No.	: N/A		
Client Reference Data	: DNF8010C(Y140409),DNF8510(Y140407),D	NF8510(Y140401)	
Received Date	: 2014.08.09		
Test Period	: 2014.08.10 to 2014.06.17		
Report Comments	: By the applicant's request, item No.s/part No report.		ed/added on
Test Results	: For further details, please refer to following p	age(s)	
		Jeff Jang / C	themical Lab Mgr
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relies in draws to the instation spony's findings at the first of its first to a transaction from essection means. Any unsufficient atheration.	of its/http: indeexistention and particulation insease delived thereis, a interestiction only and while the limits of Clarifa instanciations, if any g all their rights and obligations under the transaction documents. <i>Surgery</i> or fulfilization of the content or appearance of this document and resource here only to the surgestability.	4. enablek om respect av screatelik at <u>Attributerang</u> mensensen at <u>andre screatering at attributerang</u> (attributerang) at attributerang (attributerang) at attributerang (attributerang) at attributerang (attributerang) at attributerang (attributerang) at attributerang (attributerang) attributerang (at	in contained herein reflects to Ne document does not accessible out prior written approval of the affect actent of the law. Univer-

Test Method reference to IEC 62321 2011, 02P reference to IEC 62321 2013, 02P reference to IEC 62321 2013, 02P Test Method Test Method ferences to IEC 62321 2008, 02-MS ferences to IEC 62321 2008, 02-MS ferences to IEC 62321 2008, 02-MS	MDL 5 0.5 2 1 MDL 5	Results N.D. N.D. N.D. N.D.
reference to IEC 62221:2013, ICP reference to IEC 62221:2013, ICP reference to IEC 62221:2013, ICP iference to IEC 62221:2008, UV-VIS Test Method reference to IEC 62221:2008, IC-MS reference to IEC 62221:2008, IC-MS	5 0.5 2 1 MDL	N.D. N.D. N.D.
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eference to IEC 62321:2008, GC-MS		Results
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eference to IEC 62321:2008, GC-MS	5	N.D.
eference to IEC 62321:2008, GC-MS	5	N.D.
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		ND
ference to IEC 62321-2008 GC-MS		ND
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Test Method		
Test Method BS EN 14582:2007 , IC	MDL 30	Results N.D.
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SGS SGS 
 Test Report In:
 FS810615-CTSAVAA142857
 Issued Data

 NOTE:
 (1)N.D.- Net detected (NRL);
 (1) angle a pain
 < Test Report No. F690101/LF-CTS/ Issued Date : 2014.08.17 Page 4 of 6 14-28567 d Date : 2014.08.17 Page 3 of 6 Flow Chart of Digestion Cutting/Preparation Cd,Pb Hg Т Г inder closed(microwave) ble acid for each sample matrix nder closed(microwave) or on) system by suitable acid :h sample matrix Decomposition system by suit Picture of Sample as Rece Residue Sol Alkali Fusion ICP-AES Sample material Metal;Fe, Cu, Al, etc. Digestion Acid Aqua regia , HCI, HNOs HNOs, HCI, HF, HCIO4 AYAA14-28567.001 Plastic HNOs, H2SO4 Aqua regia HNOs, HF Silver Solder, Au, Pt, Pd, Sb, Sn her the Glass Ti, Zr, W, Mo, Si , Hf, Nb,Ta HNOs, HCI, HF HNOs, HCI, H2SOs, HBr Any acid Sn(as IEC 62321) Others ples were dissolved totally by pre Section Chief: Gilsae Yi ding to above flow chart The decare k hand by the Gray adjust to fix the end collider of fixed point ended, realish are seen in examine at collideration of the second This document and, for elect Attention is do Company's field parties to a bo Company. Any o otherwise stated to a lacend by the Company subject to its General Conditions of Service printed overlas and ferenat decomments, andject in Terma and Conditions for Shubberts Docu as to the Senderlan of Schlight, independentiation and juriedictor insease defined threads. A available on request seeds at white ages by helder of this do d Pat information cont alred hereon reflects th 222, The O valley, 70, LD-10, Donger-gu, A 1+82 (2)51 4608 000 1+82 (3)51 4606 050 Rent Lowerson? 5401



Filtration and pH Adjustment

UV-Vis

LM. 222, The O valley, 70, LD-ro, 0 1 +82 (0)01 4600 000 1 +82 (0

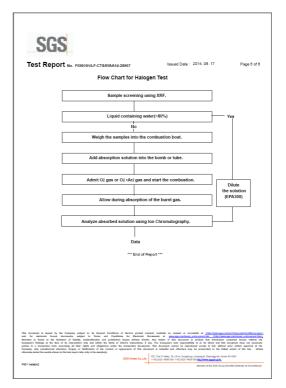
ding 1,5-Dipher for Color Dave Confirm with UV-Vis

DATA

Concentration/Dilution of Extraction Solution

GC/MS

DATA



#### 11.3 Marking Ink

Black Ink
SGS Testing KOREA co. Ltd.
Please see the 'method' in the test report
Please see the report under the table

SGS

### SGS

UUU										
Test Report	No. TSNEC1301308502	Date: 26 Dec 2013	Page 1 of 7	Test Repo	rt No. TSNEC13	01308502		Date: 26	Dec 2013	Page 2 of 7
ANTAI PARTRON ELECTR	RONICS COLTD			Test Results :						
52#. MUXIN ROAD ECON	OMIC. DEVELOPMENT ZONE MUPIN	NG YANTAI SHANDONG		Test Part Desc	disting :					
CHINA				Test Part Desc	upuur.					
				Specimen No.	SGS Sample ID Description	n				
The following complete) was	s/were submitted and identified on beh	holf of the elicete on : INI/		SN1	TSN13-013085.002 black ink					
GS Job No. :	TP13-006510 - TJ	nall of the clients as . INK.		Remarks :						
ladel No	IP-13-006510 - 13			(1) 1	mg/kg = 0.0001%					
ate of Sample Received :	23 Dec 2013			(2) M	ADL = Method Detection Limit					
esting Period :	23 Dec 2013 - 26 Dec 2013			(3) N	ID = Not Detected ( < MDL )					
est Requested :	Selected test(s) as requested by di	lient		(4)*	(4) "-" = Not Regulated					
est Method :	Please refer to next page(s).	indrine.								
est Method : est Results :	Please refer to next page(s). Please refer to next page(s).			RoHS Directive	BoHS Directive 2011/65/EU					
Conclusion :	Based on the performed tests on a Mercury, Cadmium, Hexavalent ch Polybrominated diphenyl ethers (PI Directive 2011/65/EU Annex II; rec	romium, Polybrominated big BDE) comply with the limits	henyls (PBB),	Test Method :	<ul> <li>Test Method: (1) With reference to EC 62224-62013, determination of Cadmium by (CP-OES.</li> <li>(2) With reference to EC 62224-62013, determination of Lad by (DF-OES.</li> <li>(3) With reference to EC 62224-24013, determination of Mexary by (CP-OES.</li> <li>(4) With reference to EC 62221-200, determination of Mexary by (CP-OES.</li> <li>(5) With reference to EC 62221-200, determination of Mexary by (CP-OES.</li> <li>(6) With reference to EC 62221-200, determination of Mexary by (CP-OES.</li> </ul>					
				Test Item(s)		Limit 9	Jnit M	MDL	002	
				Cadmium (Cd)			ng/kg	2	ND	
				Lead (Pb)			ng/kg	2	ND	
				Mercury (Hg) Hexavalent Chr	nomium (Cr(\/II))		ng/kg ng/kg	2	ND	
				Sum of PBBs			ng/kg		ND	
				Monobromobiph	enyl	- 11	ng/kg	5	ND	
				Dibromobiphen			ng/kg	5	ND	
igned for and on behalf of				Tribromobiphen			ng/kg	6	ND ND	
GS-CSTC Ltd.				Tetrabromobiph Pentabromobiph			ng/kg ng/kg	5	ND	
$\frown$				Hexabromobiph			ng/kg	5	ND	
1 Subres has				Heptabromobip	henyl	- 11	ng/kg	5	ND	
				Octabromobiph			ng/kg	5	ND	
eabeca Zhou				Nonabromobiph Decabromobiph			ng/kg	5	ND ND	
pproved Signatory				Sum of PBDEs	enyi		ng/kg ng/kg	5	ND	
				Monobromodipi	enyl ether		ng/kg	5	ND	
										ombarres and condition
This document is issued by the Company set top and the document format documents as a set of the document of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of the set of t	Appendix to the Generation Conditions of Device protection eventsel, ex- tension of the Conditional State of the device protection of the set optimes therein, any hotper of the devices the solution in Elever's indexed constant, the Network of Conditional Con- stant of the Terrational Constantist, The Microsoft Condi- tion of the Conditional State of the State of Conditional Con- is the Lever of Conditional Condition of Conditional Condi- tion of the Conditional Condition of Conditional Condition is the Lever of Conditional Condition of Conditional Conditional Conditional State of Conditional Conditiona			him and for marries indiffs, charged of the second se	4 pr the Conseary subject to Mar and Consear Conditions of the finant documents, majorito the finant and Conditions for and purchased patient Human. Any locater of the subject of the search distance under the Human State States and the search distance under the Human States and the search distance and the content of appears to human States and the content of appears between the states of the states and the states between the states of the states of the states and the search appears of the states of the states and the states of the states of the states of the states and the states of the states of the states of the states and the states of the states of the states of the states and the states of the states of the states of the states and the states of the states of the states of the states of the states and the states of the states of the states of the states of the states and the states of the states of the states of the states of the states and the states of the states and the states of t	Electronic Docum l courrent to activ repary's sole resp to This document ce of this document repla(s) tested .	ents al wave ag sed that informs combility is to it cannot han repr ent is unlawful a	proceedings and align contained in Client and the reduced a sense and affenders r 167 (186-22)	<ul> <li>-document him, Atlantion is increase reflects the Compan- is document does not exceed its full additional prior addition may be prosecuted to the full e0206000_1_86-20.05060555</li> </ul>	y's findings at the tim the porties to a transit approval of the Compa list estant of the law,

# Reartron

#### ACS2450HFL57

Date: 26 Dec 2013 Page 4 of 7

## SGS

Test Item(s) Antimony (Sb)

sult shown is of the total weight of wet sample

Test Report	No. TSNEC13013085	02	Date: 1	26 Dec 2013	Page 3 of 7
Test Item(s)	Limit	Unit	MDL	002	
Dibromodiphenyl ether		mg/kg	5	ND	
Tribromodiphenyl ether	-	mg/kg	5	ND	
Tetrabromodiphenyl ether	-	mg/kg	5	ND	
Pentabromodiphenyl ether	-	mg/kg	5	ND	
Hexabromodiphenyl ether		mg/kg	5	ND	
Heptabromodiphenyl ether		mg/kg	6	ND	
Octabromodiphenyl ether		mg/kg	5	ND	
Nonabromodiphenyl ether		mg/kg	5	ND	
Decabromodiphenyl ether	-	mg/kg	5	ND	
Halogen Test Method : With reference to I	EN 14582: 2007, analysi	s was per	formed by	Ion Chromatog	raph (IC).
Test Item(s)		Unit	MDL	002	
Chlorine (Cl)		ma/ka	50	ND	
Bromine (Br)		mg/kg	50	ND	
Element(s)					
Test Method : With reference to					

Unit MDL <u>202</u> mg/kg 10 ND

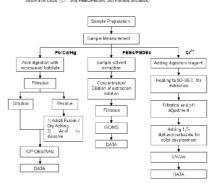
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#### Test Report No. TSNEC1301308502

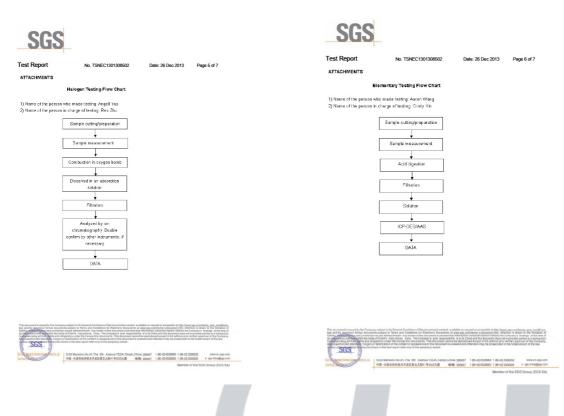
ATTACHMENTS

#### Cd/Pb/Hg/Cr<sup>8+</sup>/PBBs&PBDEs Flow Chart

 Neme of the person who made testing. Aaron Wong/Jason Li/Angeli Yao 2) Name of the person in charge of festing: Charly Yin/Rex Zhu
 These samples were disavative tatly by pre-conditioning method according to below flow chart. (C <sup>pe</sup> and PBBu/PBOEs test method accluded)



The second secon





### SGS

